

Part 0 SAR Char Report



The following samples were submitted and identified on behalf of the client as:

Equipment Under Test	Notebook Computer
Brand Name	HP
Model No.	HSN-132C
Company Name	HP Inc.
Company Address	1501 Page Mill Road, Palo Alto CA 94304 USA
Standards	IEEE/ANSI C95.1-1992, IEEE 1528-2013
FCC ID	B94HNI32CTKR
Date of Receipt	Sep. 03, 2020
Date of Test(s)	Oct. 04, 2020 ~ Oct. 06, 2020
Date of Issue	Nov. 03, 2020
In the configuration tested, the E	UT complied with the standards specified above.

Remarks:

This report details the results of the testing carried out on one sample, the results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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Signed on behalf of SGS

Clerk / Ruby Ou	Engineer / Jay Tseng	Asst. Manager / John Yeh		
Ruby Ou	Forry Tseng	John Teh		

Date: Nov. 03, 2020

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Revision History

Report Number	Revision	Description	Issue Date
ES/2020/90007	Rev.00	Initial creation of document	Nov. 03, 2020

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0. Guidance applied

The SAR testing method and procedure for this device is in accordance with the following standards: **IEEE/ANSI C95.1-1992** IEEE 1528-2013 KDB616217D04v01r02 KDB865664D01v01r04 KDB865664D02v01r02 KDB941225D01v03r01 KDB941225D05v02r05 KDB941225D05Av01r02 KDB447498D01v06

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1. General Information

1.1 Testing Laboratory

SGS Taiwan Ltd. Central RF Lab						
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City, Taiwan						
FCC Designation	TW0027					
Number	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1					
Tel	+886-2-2299-3279					
Fax	+886-2-2298-0488					
Internet	http://www.tw.sgs.com/					

1.2 Details of Applicant

Company Name	HP Inc.
Company Address	1501 Page Mill Road, Palo Alto CA 94304 USA

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1.3 Description of EUT

Equipment Under Test	Notebook Computer					
Brand Name	HP					
Model No.	HSN-I32C					
FCC ID	B94HNI32CTKR					
Integrated Module	WLAN		lame : Intel lame : AX201D2W			
Integrated Module	WWAN		lame : Fo lame : T§			
Mode of Operation	WCDMA HSDPA HSUPA HSPA+ DC-HSDPA LTE FDD LTE TDD 56 NR WLAN802.11 a/b/g/n/ac/ax(20M/40M/80M/160M) Bluetooth					
	WCDMA		100%			
	LTE FDD		100%			
	LTE TDD Power Class 3		6	63.3%		
Duty Cycle	LTE TDD Power Class 2		43.3%			
	5G NR		100%			
	WLAN802.11 a/b/g/n/ac/ax(20M/40M/80M/160M)		100%			
	Bluetooth		100%			
	Tx5 a	ntenna				
	WCDMA Band II		1850	_	1910	
	WCDMA Band IV		1710	_	1755	
TX Frequency Range (MHz)	WCDMA Band V		824	_	849	
(LTE FDD Band 2		1850	_	1910	
	LTE FDD Band 4		1710	_	1755	
	LTE FDD Band 5		824	_	849	

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	LTE FDD Band 7	2500	_	2570		
	LTE FDD Band 12	699	_	716		
	LTE FDD Band 13	777	_	787		
	LTE FDD Band 14	788	_	798		
	LTE FDD Band 17	704	_	716		
	LTE FDD Band 25	1850	_	1915		
	LTE FDD Band 26	814	_	849		
	LTE FDD Band 30	2305	_	2315		
	LTE TDD Band 38 Power Class 3	2570	_	2620		
	LTE TDD Band 41 Power Class 2/3	2496	_	2690		
	LTE FDD Band 66	1710	_	1780		
	n2	1850	_	1910		
	n5	824	_	849		
	n12	699	_	716		
TX Frequency Range	n66	1710	_	1780		
(MHz)	Tx8 antenna					
	LTE FDD Band 2	1850	_	1910		
	LTE FDD Band 7	2500	_	2570		
	LTE FDD Band 42 Power Class 3	3400	_	3600		
	LTE FDD Band 48 Power Class 3	3550	_	3700		
	LTE FDD Band 66	1710	_	1780		
	n2	1850	_	1910		
	n7	2500	_	2570		
	n41 Power Class 2/3	2496	_	2690		
	n66	1710	_	1780		
	WLAN/BT					
	WLAN802.11 b/g/n/ax(20M)	2412	_	2472		
	WLAN802.11 n/ax(40M)	2422	_	2462		

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	WLAN802.11 a/n/ac/ax(20M) 5.2G	5180	_	5240	
	WLAN802.11 n/ac/ax(40M) 5.2G	5190	_	5230	
	WLAN802.11 ac/ax(80M) 5.2G		5210		
	WLAN802.11 ac/ax(160M) 5.2G		5250		
	WLAN802.11 a/n/ac/ax(20M) 5.3G	5260	_	5320	
	WLAN802.11 n/ac/ax(40M) 5.3G	5270	—	5310	
TX Frequency Range	WLAN802.11 ac/ax(80M) 5.3G		5290		
(MHz)	WLAN802.11 a/n/ac/ax(20M) 5.6G	5500	—	5720	
	WLAN802.11 n/ac/ax(40M) 5.6G	5510	—	5710	
	WLAN802.11 ac/ax(80M) 5.6G	5530	_	5690	
	WLAN802.11 ac/ax(160M) 5.6G	5570			
	WLAN802.11 a/n/ac/ax(20M) 5.8G	5745	_	5825	
	WLAN802.11 n/ac/ax(40M) 5.8G	5755	_	5795	
	WLAN802.11 ac/ax(80M) 5.8G		5775		
	Bluetooth	2402	—	2480	
	Tx5 antenna				
	WCDMA Band II	9262	—	9538	
	WCDMA Band IV	1312	—	1513	
	WCDMA Band V	4132	—	4233	
	LTE FDD Band 2	18607	_	19193	
Channel Number	LTE FDD Band 4	19957	_	20393	
(ARFCN)	LTE FDD Band 5	20407	_	20643	
	LTE FDD Band 7	20775	_	21425	
	LTE FDD Band 12	23017	_	23173	
	LTE FDD Band 13	23205	_	23255	
	LTE FDD Band 14	23305	_	23355	
	LTE FDD Band 17	23755	_	23825	

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	LTE FDD Band 25	26047	_	26683		
	LTE FDD Band 26	26697	_	27033		
	LTE FDD Band 30	27685	_	27735		
	LTE TDD Band 38 Power Class 3	37775	_	38225		
	LTE TDD Band 41 Power Class 2/3	39675	_	41565		
	LTE FDD Band 66	131979	_	132665		
	n2	370500	_	381500		
	n5	165300	_	169300		
	n12	140300	_	142200		
	n66	342500	_	355500		
	Tx8 antenna					
	LTE FDD Band 2	18607	_	19193		
	LTE FDD Band 7	20775	_	21425		
	LTE FDD Band 42 Power Class 3	41615	_	43565		
Channel Number	LTE FDD Band 48 Power Class 3	55265	_	56715		
(ARFCN)	LTE FDD Band 66	131979	_	132665		
	n2	370500	_	381500		
	n7	500500	_	513500		
	n41 Power Class 2/3	501204	_	535998		
	n66	342500	_	355500		
	WLAN/BT					
	WLAN802.11 b/g/n/ax(20M)	1	_	13		
	WLAN802.11 n/ax(40M)	3	_	11		
	WLAN802.11 a/n/ac/ax(20M) 5.2G	36	—	48		
	WLAN802.11 n/ac/ax(40M) 5.2G	38	—	46		
	WLAN802.11 ac/ax(80M) 5.2G		42			
	WLAN802.11 ac/ax(160M) 5.2G		50			
	WLAN802.11 a/n/ac/ax(20M) 5.3G	52	_	64		
	WLAN802.11 n/ac/ax(40M) 5.3G	54	_	62		

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	WLAN802.11 ac/ax(80M) 5.3G		58	
	WLAN802.11 a/n/ac/ax(20M) 5.6G	100	—	144
	WLAN802.11 n/ac/ax(40M) 5.6G	102	—	142
	WLAN802.11 ac/ax(80M) 5.6G	106	—	138
Channel Number	WLAN802.11 ac/ax(160M) 5.6G	114		
(ARFCN)	WLAN802.11 a/n/ac/ax(20M) 5.8G	149	_	165
	WLAN802.11 n/ac/ax(40M) 5.8G	151	—	159
	WLAN802.11 ac/ax(80M) 5.8G		155	
	Bluetooth	0	_	78

This device uses the Qualcomm® Smart Transmit feature to control and manage transmitting power in real time and to ensure the time-averaged RF exposure is in compliance with the FCC requirement at all times for 3G/4G/5G Sub-6 NR WWAN operations. Additionally, this device supports WLAN/BT technologies, but the output power of these modems is not controlled by the Smart Transmit algorithm.

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Gain (dBi)

1.17

Notebook mode							
Vendor		AWAN					
Antenna			Μ	lian Tx5 (PIF/	4)		
Part Number			6036B028	5701(AUF6)	(-100027)		
Frequency	699~716	777~798	814~849	1710~1780	1850~1915	2300~2400	2496~2690
Gain (dBi)	-4.53	-3.46	-0.89	1.95	1.79	2.04	0.41
			Tablet	mode			
Vendor				AWAN			
Antenna			Μ	lian Tx5 (PIF	4)		
Part Number			6036B028	35701(AUF6`	Y-100027)		
Frequency	699~716	777~798	814~849	1710~1780	1850~1915	2300~2400	2496~2690
Gain (dBi)	-7.42	-5.07	-3.38	-2.38	-1.15	-4.79	-5.30
	No	tebook moo	de				
Vendor		AM	/AN				
Antenna		Aux3 Tx	8 (PIFA)				
Part Number	603	6B0285301(AUP6Y-1000	093)			
Frequency	1710-1780	1850-1910	2496~2690	3550-3700			

-3.55

-2.43

Tablet mode									
Vendor	AWAN								
Antenna		Aux3 Tx8 (PIFA)							
Part Number	603	6B0285301(AUP6Y-1000	093)					
Frequency	1710-1780	1850-1910	2496~2690	3550-3700					
Gain (dBi)	-0.33	-1.78	-2.22	-5.77					

1.62

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1.4 Time-Averaging for SAR

This device is enabled with Qualcomm® Smart Transmit algorithm to control and manage transmitting power in real time and to ensure that the time-averaged RF exposure from 3G/4G/5G Sub-6 NR WWAN is in compliance with FCC requirements. This Part 0 report shows SAR characterization of WWAN radios for 3G/4G and 5G Sub-6 NR. Characterization is achieved by determining Plimit for 3G/4G and 5G Sub-6 NR that correspond to the exposure design targets after accounting for all device design related uncertainties, i.e., SAR design target (< FCC SAR limit) for sub-6 radio. The SAR characterization is denoted as SAR Char in this report. Section 1.5 includes a nomenclature of the specific terms used in this report.

The compliance test under the static transmission scenario and simultaneous transmission analysis are reported in Part 1 report. The validation of the time-averaging algorithm and compliance under the dynamic (time-varying) transmission scenario for WWAN technologies are reported in Part 2 report (report Number could be found in Section 1.6 – Bibliography).

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1.5 Nomenclature for Part 0 Report

Technology	Term	Description			
20/40/50	Plimit	The time-averaged RF power which corresponds to SAR_design_target			
3G/4G/5G Pmax Sub-6 NR SAR_design_target		Maximum tune-up power level			
		The SAR design target for SAR compliance. It shall be			
		less than SAR limit after accounting for all device design			
		related uncertainties.			
	SAR Char	Plimit for all technologies/bands for all applicable DSI			

1.6 Bibliography

Report Type	Report Number
FCC SAR Test Report (Part 1)	ES/2020/90007
RF Exposure Part 2 Test Report	ES/2020/90007

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1.7 Test Environment

Ambient Temperature: 22±2° C Tissue Simulating Liquid: 22±2° C

1.8 Operation Description

For WWAN, the EUT is controlled by using a Radio Communication Tester, and the communication between the EUT and the tester is established by air link. The device was tested based on FCC guidance (KDB inquiry).

Notebook mode

SAR is measured with display screen open at 90 degree and bottom side of keyboard touch against the flat phantom.

Tablet mode

SAR is measured with backside/edges of tablet mode touch against the flat phantom.

Note

1. For WWAN, there are two TX antennas, the one is WWAN 5 TX located on the keyboard section, the other is WWAN 8 TX antenna located on the top edge of display screen. In order to mitigate RF exposure concern, Qualcomm smart transmit is used in WWAN.

2. For laptop SAR of WWAN 8 TX, SAR is excluded from testing based on the following test exclusion table.

La	aptop Mode	LTE B2	LTE B7	LTE B42	LTE B48	LTE B66	n2	n7	n41	n41(HPUE)	n66
Max. tun	e-up power(dBm)	24	24	24	22	24	24	24	24	27	24
Max. tun	ie-up power(mW)	251.189	251.189	251.189	158.489	251.189	251.189	251.189	251.189	501.187	251.189
	Test separation distance (mm)	198	198	198	198	198	198	198	198	198	198
Bottom side	Calculation value	1588.536	1573.567	1559.057	1557.981	1592.430	1588.536	1573.567	1571.457	1571.457	1592.430
	Require SAR testing?	NO	NO								

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1.9 The SAR Measurement System

A block diagram of the SAR measurement System is given in Fig. a. This SAR Measurement System uses a Computer-controlled 3-D stepper motor system (SPEAG DASY 5 professional system). The model EX3DV4 field probe is used to determine the internal electric fields. The SAR can be obtained from the equation SAR= σ (|Ei|²)/ ρ where σ and ρ are the conductivity and mass density of the tissue-simulant.

The DASY 5 system for performing compliance tests consists of the following items:

- 1. A standard high precision 6-axis robot (Staubli RX family) with controller, teach pendant and software. An arm extension is for accommodating the data acquisition electronics (DAE).
- 2. A dosimetric probe, i.e., an isotropic E-field probe optimized and calibrated for usage intissue simulating liquid. The probe is equipped with an optical surface detector system.
- 3. A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.

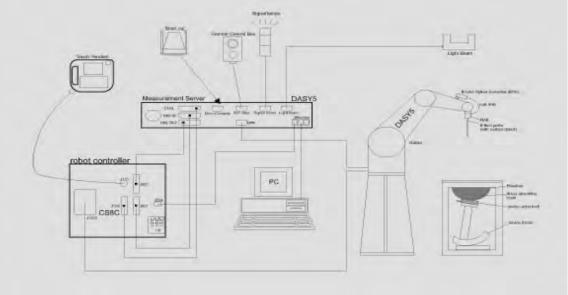


Fig. a The block diagram of SAR system

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- 4. The Electro-optical converter (EOC) performs the conversion between optical and electrical of the signals for the digital communication to the DAE and for the analog signal from the optical surface detection. The EOC is connected to the measurement server.
- 5. The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- 6. A probe alignment unit which improves the (absolute) accuracy of the probe positioning.
- 7. A computer operating Windows 7.
- 8. DASY 5 software.
- 9. Remote control with teach pendant and additional circuitry for robot safety such as warning lamps, etc.
- 10. Tissue simulating liquid mixed according to the given recipes.
- 11. Validation dipole kits allowing to validate the proper functioning of the system.

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1.10 System Components

EX3DV4 E-Field Probe

Construction	Symmetrical design with triangular core	
	Built-in shielding against static charges	a second and
	PEEK enclosure material (resistant to organic	
	solvents, e.g., DGBE)	
Calibration	Basic Broad Band Calibration in air Conversion Factors (CF) for HSL 750/835/1750/1900/2300/2600/3500/3700MHz Additional CF for other liquids and frequencies upon request	
Frequency	10 MHz to > 6 GHz	
Directivity	± 0.3 dB in HSL (rotation around probe axis)	
	± 0.5 dB in tissue material (rotation normal to pr	obe axis)
Dynamic	10 μW/g to > 100 mW/g	
Range	Linearity: ± 0.2 dB (noise: typically < 1 µW/g)	
Dimensions	Tip diameter: 2.5 mm	
Application	High precision dosimetric measurements in any	v exposure scenario (e.g.,
	very strong gradient fields). Only probe which er	nables compliance testing
	for frequencies up to 6 GHz with precision of be	etter 30%.

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PHANTOM

Model	ELI						
Construction	The ELI phantom is used for compliance testing of handheld and						
	ody-mounted wireless devices in the frequency range of 30 MHz to						
	6 GHz. ELI is fully compatible with the IEC 62209-2 standard and all						
	known tissue simulating liquids. ELI has been optimized regarding its						
	performance and can be integrated into our standard phantom						
	tables. A cover prevents evaporation of the liquid. Reference						
	markings on the phantom allow installation of the complete setup,						
	including all predefined phantom positions and measurement grids,						
	by teaching three points. The phantom is compatible with all SPEAG						
	dosimetric probes and dipoles.						
Shell Thickness	2 ± 0.2 mm						
Filling Volume	Approx. 30 liters						
Dimensions	Major axis: 600 mm						
	Minor axis: 400 mm						

DEVICE HOLDER

Construction	The device holder (Supporter) for Notebook is made by POM (polyoxymethylene resin) , which is non-metal and non-conductive. The height can	
	be adjusted to fit varies kind of notebooks.	
		Device Holder

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1.11 Evaluation Procedures

The entire evaluation of the spatial peak values is performed within the Post-processing engine (SEMCAD). The system always gives the maximum values for the 1 g and 10 g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- 1. The extraction of the measured data (grid and values) from the Zoom Scan.
- 2. The calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- 3. The generation of a high-resolution mesh within the measured volume
- 4. The interpolation of all measured values from the measurement grid to the high-resolution grid
- 5. The extrapolation of the entire 3-D field distribution to the phantom surface over the distance from sensor to surface
- 6. The calculation of the averaged SAR within masses of 1g and 10g.

The probe is calibrated at the center of the dipole sensors that is located 1 to 2.7mm away from the probe tip. During measurements, the probe stops shortly above the phantom surface, depending on the probe and the surface detecting system. Both distances are included as parameters in the probe configuration file. The software always knows exactly how far away the measured point is from the surface. As the probe cannot directly measure at the surface, the values between the deepest measured point and the surface must be extrapolated. The angle between the probe axis and the surface normal line is less than 30 degree.

In the Area Scan, the gradient of the interpolation function is evaluated to find all the extreme of the SAR distribution. The uncertainty on the locations of the extreme is less than 1/20 of the grid size. Only local maximum within -2 dB of the global maximum are searched and passed for the Cube Scan measurement. In the Cube Scan, the interpolation function is used to extrapolate the Peak SAR from the lowest measurement points to the inner phantom surface (the extrapolation distance). The uncertainty increases with the extrapolation distance. To keep the uncertainty within 1% for the 1 g and 10 g cubes, the extrapolation distance should not be larger than 5mm.

The maximum search is automatically performed after each area scan measurement. It is based on splines in two or three dimensions. The procedure can find the maximum for most SAR distributions even with relatively large grid spacing. After the area scanning measurement, the probe is automatically moved to a position at the interpolated maximum. The following scan can directly use this position for reference, e.g., for a finer resolution grid or the cube evaluations. The 1g and 10g peak evaluations are only available for the predefined cube 7x7x7 scans. The routines are verified and optimized for the grid dimensions used in these cube measurements.

The measured volume of 30x30x30mm contains about 30g of tissue. The first procedure is an extrapolation (incl. Boundary correction) to get the points

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between the lowest measured plane and the surface. The next step uses 3D interpolation to get all points within the measured volume. In the last step, a 1g cube is placed numerically into the volume and its averaged SAR is calculated. This cube is the moved around until the highest averaged SAR is found. If the highest SAR is found at the edge of the measured volume, the system will issue a warning: higher SAR values might be found outside of the measured volume. In that case the cube measurement can be repeated, using the new interpolated maximum as the center.

1.12 Probe Calibration Procedures

For the calibration of E-field probes in lossy liquids, an electric field with an accurately known field strength must be produced within the measured liquid. For standardization purposes it would be desirable if all measurements which are necessary to assess the correct field strength would be traceable to standardized measurement procedures. In the following two different calibration techniques are summarized:

1.12.1 Transfer Calibration with Temperature Probes

In lossy liquids the specific absorption rate (SAR) is related both to the electric field (*E*) and the temperature gradient ($\delta T / \delta t$) in the liquid.

$$SAR = \frac{\sigma}{\rho} \left| E \right|^2 = C \frac{\delta T}{\delta t}$$

whereby σ is the conductivity, ρ the density and c the heat capacity of the liquid.

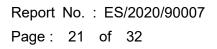
Hence, the electric field in lossy liquid can be measured indirectly by measuring the temperature gradient in the liquid. Non-disturbing temperature probes (optical probes or thermistor probes with resistive lines) with high spatial resolution (<1-2 mm) and fast reaction time (<1 s) are available and can be easily calibrated with high precision [1]. The setup and the exciting source have no influence on the calibration; only the relative positioning uncertainties of the standard temperature probe and the E-field probe to be calibrated must be considered. However, several problems limit the available accuracy of probe calibrations with temperature probes:

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- 1. The temperature gradient is not directly measurable but must be evaluated from temperature measurements at different time steps. Special precaution is necessary to avoid measurement errors caused by temperature gradients due to energy equalizing effects or convection currents in the liquid. Such effects cannot be completely avoided, as the measured field itself destroys the thermal equilibrium in the liquid. With a careful setup these errors can be kept small.
- 2. The measured volume around the temperature probe is not well defined. It is difficult to calculate the energy transfer from a surrounding gradient temperature field into the probe. These effects must be considered, since temperature probes are calibrated in liquid with homogeneous temperatures. There is no traceable standard for temperature rise measurements.
- 3. The calibration depends on the assessment of the specific density, the heat capacity and the conductivity of the medium. While the specific density and heat capacity can be measured accurately with standardized procedures (~ 2% for c; much better for ρ), there is no standard for the measurement of the conductivity. Depending on the method and liquid, the error can well exceed ±5%.
- 4. Temperature rise measurements are not very sensitive and therefore are often performed at a higher power level than the E-field measurements. The nonlinearities in the system (e.g., power measurements, different components, etc.) must be considered.

Considering these problems, the possible accuracy of the calibration of E-field probes with temperature gradient measurements in a carefully designed setup is about ±10% (RSS) [2]. Recently, a setup which is a combination of the waveguide techniques and the thermal measurements was presented in [3]. The estimated uncertainty of the setup is $\pm 5\%$ (RSS) when the same liquid is used for the calibration and for actual measurements and ±7-9% (RSS) when not, which is in good agreement with the estimates given in [2].

1.12.2 Calibration with Analytical Fields

In this method a technical setup is used in which the field can be calculated analytically from measurements of other physical magnitudes (e.g., input power). This corresponds to the standard field method for probe calibration in air; however, there is no standard defined for fields in lossy liquids.

When using calculated fields in lossy liquids for probe calibration, several points must be considered in the assessment of the uncertainty:

- 1. The setup must enable accurate determination of the incident power.
- 2. The accuracy of the calculated field strength will depend on the assessment of the dielectric parameters of the liquid.

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3. Due to the small wavelength in liquids with high permittivity, even small setups might be above the resonant cutoff frequencies. The field distribution in the setup must be carefully checked for conformity with the theoretical field distribution.

References

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- K. Meier, M. Burkhardt, T. Schmid, and N. Kuster, \Broadband 2. calibration of E-field probes in lossy media", IEEE Transactions on Microwave Theory and Techniques, vol. 44, no. 10, pp. 1954{1962, Oct. 1996.
- K. Jokela, P. Hyysalo, and L. Puranen, \Calibration of specific 3. absorption rate (SAR) probes in waveguide at 900 MHz", IEEE Transactions on Instrumentation and Measurements, vol. 47, no. 2, pp. 432{438, Apr. 1998.

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1.13 Test Standards and Limits

According to FCC 47CFR §2.1093(d) The limits to be used for evaluation are based generally on criteria published by the American National Standards Institute (ANSI) for localized specific absorption rate ("SAR") in Section 4.2 of "IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz," ANSI/IEEE C95.1, By the Institute of Electrical and Electronics Engineers, Inc., New York, New York 10017. These criteria for SAR evaluation are similar to those recommended by the National Council on Radiation Protection and Measurements (NCRP) in "Biological Effects and Exposure Criteria for Radio frequency Electromagnetic Fields," NCRP Report No. 86, Section 17.4.5. Copyright NCRP, 1986, Bethesda, Maryland 20814. SAR is a measure of the rate of energy absorption due to exposure to an RF transmitting source. SAR values have been related to threshold levels for potential biological hazards. The criteria to be used are specified in paragraphs (d)(1) and (d)(2) of this section and shall apply for portable devices transmitting in the frequency range from 100 kHz to 6 GHz. Portable devices that transmit at frequencies above 6 GHz are to be evaluated in terms of the MPE limits specified in § 1.1310 of this chapter. Measurements and calculations to demonstrate compliance with MPE field strength or power density limits for devices operating above 6 GHz should be made at a minimum distance of 5 cm from the radiating source.

- Limits for Occupational/Controlled exposure: 0.4 W/kg as averaged over the 1. whole-body and spatial peak SAR not exceeding 8 W/kg as averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube). Exceptions are the hands, wrists, feet and ankles where the spatial peak SAR shall not exceed 20 W/kg, as averaged over an 10 grams of tissue (defined as a tissue volume in the shape of a cube).
- 2. Occupational/Controlled limits apply when persons are exposed as a consequence of their employment provided these persons are fully aware of and exercise control over their exposure. Awareness of exposure can be accomplished by use of warning labels or by specific training or education through appropriate means, such as an RF safety program in a work environment.
- Limits for General Population/Uncontrolled exposure: 0.08 W/kg as averaged 3. over the whole-body and spatial peak SAR not exceeding 1.6 W/kg as averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube). Exceptions are the hands, wrists, feet and ankles where the spatial peak SAR shall not exceed 4 W/kg, as averaged over any 10 grams of

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tissue (defined as a tissue volume in the shape of a cube). General Population/Uncontrolled limits apply when the general public may be exposed, or when persons that are exposed as a consequence of their employment may not be fully aware of the potential for exposure or do not exercise control over their exposure. Warning labels placed on consumer devices such as cellular telephones will not be sufficient reason to allow these devices to be evaluated subject to limits for occupational/controlled exposure in paragraph (d)(1) of this section. (Table 4.)

Human Exposure	Uncontrolled Environment General Population	Controlled Environment Occupational		
Spatial Peak SAR (Brain)	1.60 W/Kg	8.00 W/Kg		
Spatial Average SAR (Whole Body)	0.08 W/Kg	0.40 W/Kg		
Spatial Peak SAR (Hands/Feet/Ankle/Wrist)	4.00 W/Kg	20.00 W/Kg		

Table 4. RF exposure limits

Notes:

- 1. Uncontrolled environments are defined as locations where there is potential exposure of individuals who have no knowledge or control of their potential exposure.
- 2. Controlled environments are defined as locations where there is potential exposure of individuals who have knowledge of their potential exposure and can exercise control over their exposure.

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2. Instruments List

Manufacturer	Device	Туре	Serial number	Date of last calibration	Date of next calibration
SPEAG	Dosimetric E-Field Probe	EX3DV4	7509	Mar.25,2020	Mar.24,2021
		D750V3	1015	Aug.13,2020	Aug.12,2021
		D835V2	4d063	Aug.13,2020	Aug.12,2021
		D1750V2	1008	Aug.14,2020	Aug.13,2021
	System Validation	D1900V2	5d173	Apr.22,2020	Apr.21,2021
SPEAG	Dipole	D2300V2	1023	Aug.13,2020	Aug.12,2021
		D2600V2	1005	Jan.29,2020	Jan.28,2021
		D3500V2	1009	Aug.12,2020	Aug.11,2021
		D3700V2	1057	Nov.04,2019	Nov.03,2020
SPEAG	Data acquisition Electronics	DAE4	877	Mar.17,2020	Mar.16,2021
SPEAG	Software	DASY 52 V52.10.4	N/A	Calibration not required	Calibration not required
SPEAG	Phantom	ELI	N/A	Calibration not required	Calibration not required
Agilent	Network Analyzer	E5071C	MY46100433	Dec.13,2019	Dec.12,2020
Agilent	Dielectric Probe Kit	85070E	MY44300677	Calibration not required	Calibration not required
Agilent	Dual-directional	772D	MY46151242	Aug.17,2020	Aug.16,2021
Aglient	coupler	778D	MY48220468	Aug.17,2020	Aug.16,2021
Agilent	RF Signal Generator	N5181A	MY50141235	May.04,2020	May.03,2021
Agilent	Power Meter	E4417A	MY51410006	Mar.09,2020	Mar.08,2021
Apilort	Power Sensor		MY51470001	Mar.09,2020	Mar.08,2021
Agilent		E9301H	MY51470002	Mar.09,2020	Mar.08,2021

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Manufacturer	Device	Device Type		Date of last calibration	Date of next calibration
TECPEL	Digital thermometer	DTM-303A	TP130074	Apr.10,2020	Apr.09,2021
Anritsu	Radio Communication Test	MT8820C	6201061049	Dec.08,2019	Dec.07,2020
R&S	Radio Communication Test	CMW 500	125470	Dec.11,2019	Dec.10,2020

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3. Uncertainty Budget

Measurement Uncertainty evaluation template for DUT SAR test (3-6G)

A	с	D	е		f	g	h=c * f / e	i=c * g / e	k
Source of Uncertainty	Tolerance/ Uncertainty	Probabilit y	Div	Div Value	ci (1g)	ci (10g)	Standard uncertainty	Standard uncertainty	vi, or Vef
Measurement system									
Probe calibration	6.55%	Ν	1	1	1	1	6.55%	6.55%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Isotropy , Axial	3.50%	R	√3	1.732	1	1	2.02%	2.02%	∞
lsotropy, Hemispherical	9.60%	R	√3	1.732	1	1	5.54%	5.54%	∞
Modulation Response	2.40%	R	√3	1.732	1	1	1.40%	1.40%	∞
Boundary Effect	1.00%	R	√3	1.732	1	1	0.58%	0.58%	∞
Linearity	4.70%	R	√3	1.732	1	1	2.71%	2.71%	∞
Detection Limits	1.00%	R	√3	1.732	1	1	0.58%	0.58%	∞
Readout Electronics	0.30%	N	1	1	1	1	0.30%	0.30%	∞
Response time	0.80%	R	√3	1.732	1	1	0.46%	0.46%	∞
Integration Time	2.60%	R	√3	1.732	1	1	1.50%	1.50%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Measurement drift (class A evaluation)	1.75%	R	√3	1.732	1	1	1.01%	1.01%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
RF ambient condition - noise	3.00%	R	√3	1.732	1	1	1.73%	1.73%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
RF ambient conditions - reflections	3.00%	R	√3	1.732	1	1	1.73%	1.73%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Probe positioner Mechanical restrictions	0.40%	R	√3	1.732	1	1	0.23%	0.23%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Probe Positioning with respect to phantom	2.90%	R	√3	1.732	1	1	1.67%	1.67%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Post-processing	1.00%	R	√3	1.732	1	1	0.58%	0.58%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Max SAR Eval	1.00%	R	√3	1.732	1	1	0.58%	0.58%	~
Test Sample related									
Test sample positioning	2.90%	Ν	1	1	1	1	2.90%	2.90%	M-1
Device Holder Uncertainty	3.60%	Ν	1	1	1	1	3.60%	3.60%	M-1
Drift of output power	5.00%	R	√3	1.732	1	1	2.89%	2.89%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Phantom and Setup									
Phantom Uncertainty	4.00%	R	√3	1.732	1	1	2.31%	2.31%	∞
Liquid permittivity (mea.)	0.72%	N	1	1	0.64	0.43	0.46%	0.31%	М
Liquid Conductivity (mea.)	1.68%	N	1	1	0.6	0.49	1.01%	0.82%	М
Combined standard uncertainty		RSS					11.77%	11.74%	
Expant uncertainty (95% confidence							23.54%	23.48%	

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Measurement Uncertainty evaluation template for DUT SAR test (0.3-3G)

A	с	D	е		f	g	h=c * f / e	i=c * g / e	k
Source of Uncertainty	Tolerance/ Uncertainty	Probabilit y	Div	Div Value	ci (1g)	ci (10g)	Standard uncertainty	Standard uncertainty	vi, or Veff
Measurement system									
Probe calibration	6.00%	N	1	1	1	1	6.00%	6.00%	œ
Isotropy , Axial	3.50%	R	√3	1.732	1	1	2.02%	2.02%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Isotropy, Hemispherical	9.60%	R	√3	1.732	1	1	5.54%	5.54%	~
Modulation Response	2.40%	R	√3	1.732	1	1	1.40%	1.40%	~
Boundary Effect	1.00%	R	√3	1.732	1	1	0.58%	0.58%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Linearity	4.70%	R	√3	1.732	1	1	2.71%	2.71%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Detection Limits	1.00%	R	√3	1.732	1	1	0.58%	0.58%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Readout Electronics	0.30%	N	1	1	1	1	0.30%	0.30%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Response time	0.80%	R	√3	1.732	1	1	0.46%	0.46%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Integration Time	2.60%	R	√3	1.732	1	1	1.50%	1.50%	~
Measurement drift (class A evaluation)	1.75%	R	√3	1.732	1	1	1.01%	1.01%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
RF ambient condition - noise	3.00%	R	√3	1.732	1	1	1.73%	1.73%	~
RF ambient conditions - reflections	3.00%	R	√3	1.732	1	1	1.73%	1.73%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Probe positioner Mechanical restrictions	0.40%	R	√3	1.732	1	1	0.23%	0.23%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Probe Positioning with respect to phantom	2.90%	R	√3	1.732	1	1	1.67%	1.67%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Post-processing	1.00%	R	√3	1.732	1	1	0.58%	0.58%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Max SAR Eval	1.00%	R	√3	1.732	1	1	0.58%	0.58%	~
Test Sample related									
Test sample positioning	2.90%	N	1	1	1	1	2.90%	2.90%	M-1
Device Holder Uncertainty	3.60%	N	1	1	1	1	3.60%	3.60%	M-1
Drift of output power	5.00%	R	√3	1.732	1	1	2.89%	2.89%	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
Phantom and Setup									
Phantom Uncertainty	4.00%	R	√3	1.732	1	1	2.31%	2.31%	∞
Liquid permittivity (mea.)	2.50%	N	1	1	0.64	0.43	1.60%	1.08%	М
Liquid Conductivity (mea.)	4.55%	N	1	1	0.6	0.49	2.73%	2.23%	М
Combined standard uncertainty		RSS					11.85%	11.67%	
Expant uncertainty (95% confidence							23.70%	23.35%	

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4. SAR Characterization

4.1 SAR_design_target and Uncertainty

SAR design target is determined by ensuring that it is less than FCC SAR limit after accounting for total device designed related uncertainties specified by the manufacturer (see Table 4-1).

SAR design target < SAR limit x 10 $^{-total uncertainty/10}$

	Uncertainty dB (k=2)
Total uncertainty	1.0

Exposure	Antenna	Frequency band	SAR_design_target
Laptop mode	Tx5	All	1.11 W/Kg
	Tx8	All	0.635 W/Kg

Exposure	Antenna	Frequency band	SAR_design_target
Tablet mode	Tx5	All	1.16 W/Kg
	Tx8	All	0.635 W/Kg

4.2 SAR Characterization

SAR test results corresponding to Pmax for each antenna/technology/band/DSI can be found in next chapter.

Plimit is calculated by linearly scaling the measured SAR at the Pmax to SAR design target. Plimit determination corresponding to SAR design target are shown in next chapter.

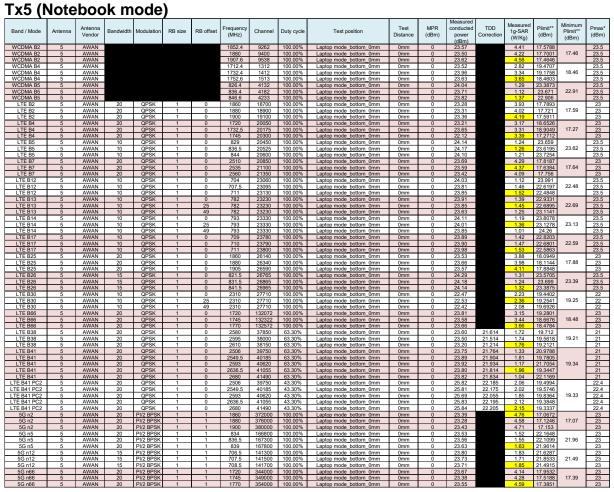
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5. SAR test results for Plimit calculations



* Pmax is used for RF tune-up procedure. The maximum allowed output power is equal to Pmax + 1dB uncertainty.

** All Plimit power levels in above table corresponding to average power levels after accounting for duty cycle in the case TDD modulation schemes (LTE TDD).

The maximum allowed output power is the Plimit + 1dB device uncertainty, and if Plimit is higher than Pmax, the device output power will be Pmax instead.

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Measured

Tx5 (Tablet mode)

Band / Mode	Antenna	Antenna Vendor	Bandwidth	Modulation	RB size	RB offset	Frequency (MHz)	Channel	Duty cycle	Test position	Test Distance	MPR (dBm)	Measured conducted power (dBm)	TDD Correction	Measured 1g-SAR (W/Kg)	Plimit** (dBm)	Minimum Plimit** (dBm)	Pmax* (dBm)
WCDMA B2 WCDMA B2	5	AWAN AWAN					1852.4 1880	9262 9400	100.00% 100.00%	TB mode_back_0mm TB mode back 0mm	0mm 0mm	0	23.57 23.50		9.44	14.46 14.28		23.5 23.5
WCDMA B2	5	AWAN					1907.6	9538	100.00%	TB mode back 0mm	0mm	0	23.62		9.69	14.57	14.28	23.5
WCDMA B2 WCDMA B2	5	AWAN					1907.6 1907.6	9538 9538	100.00%	TB mode Left side 0mm TB mode Top side 0mm	0mm 0mm	0	23.62 23.62		4.04	18.20 23.77		23.5 23.5
WCDMA B4 WCDMA B4	5	AWAN					1712.4 1732.4	1312 1412	100.00%	TB mode back 0mm TB mode back 0mm	0mm 0mm	0	23.52 23.96		7.75	15.27 15.95		23.5 23.5
WCDMA B4 WCDMA B4	5	AWAN					1752.6 1732.4	1513 1412	100.00%	TB mode_back_0mm TB mode_Left side_0mm	0mm 0mm	0	23.63 23.96		7.45	15.55	15.27	23.5
WCDMA B4	5	AWAN					1732.4	1412	100.00%	TB mode_Top side_0mm	0mm	0	23.96		0.717	26.05		23.5
WCDMA B5 WCDMA B5	5	AWAN AWAN					826.4 836.4	4132 4182	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	24.04 23.71		2.48 2.47	20.74 20.43		23.5
WCDMA B5 WCDMA B5	5 5	AWAN					846.6 826.4	4233 4132	100.00%	TB mode back 0mm TB mode Left side 0mm	0mm 0mm	0	23.82 24.04		2.61	20.30 20.97	20.30	23.5 23.5
WCDMA B5	5	AWAN					826.4	4132	100.00%	TB mode Top side 0mm	0mm	0	24.04		0.263	30.49		23.5
LTE B2 LTE B2	5	AWAN AWAN	20 20	QPSK QPSK	1	0	1860 1880	18700 18900	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	23.28 23.31		7.21	15.35 15.32		23 23
LTE B2 LTE B2	5	AWAN	20 20	QPSK QPSK	1	0	1900 1900	19100 19100	100.00%	TB mode_back_0mm TB mode_Left side_0mm	0mm 0mm	0	23.36 23.36		7.12	15.48 18.22	15.32	23
LTE B2 LTE B4	5	AWAN	20	QPSK QPSK	1	0	1900 1720	19100 20050	100.00%	TB mode_Top side_0mm TB mode_back_0mm	0mm 0mm	0	23.36		0.962	24.17		23 23
LTE B4	5	AWAN	20	QPSK	1	Ő	1732.5	20175	100.00%	TB mode_back_0mm	0mm	0	23.65		6.12	16.43	15.87	23
LTE B4 LTE B4	5	AWAN AWAN	20 20	QPSK QPSK	1	0	1745 1745	20300 20300	100.00% 100.00%	TB mode back 0mm TB mode Left side 0mm	0mm 0mm	0	22.12 23.65		4.67 3.69	16.07 18.62	15.87	23 23
LTE B4 LTE B5	5	AWAN AWAN	20	QPSK QPSK	1	0	1732.5 829	20175 20450	100.00% 100.00%	TB mode Top side 0mm TB mode back 0mm	0mm 0mm	0	23.65 24.14		0.757 2.34	25.50 21.09		23 23.5
LTE B5 LTE B5	5	AWAN AWAN	10	QPSK QPSK	1	0	836.5 844	20525 20600	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	Omm Omm	0	24.17 24.10		2.21	21.37 20.77	20.77	23.5 23.5
LTE B5	5	AWAN	10	QPSK	1	0	836.5	20525	100.00%	TB mode_Left side_0mm	0mm	0	24.17		2.0	21.59	20.11	23.5
LTE B5 LTE B7	5	AWAN AWAN	10 20	QPSK QPSK	1	0	836.5 2510	20525 20850	100.00% 100.00%	TB mode_Top side_0mm TB mode_back_0mm	0mm 0mm	0	24.17 23.69		0.311 10.7	29.89 14.04		23.5 23
LTE B7 LTE B7	5	AWAN AWAN	20	QPSK QPSK	1	0	2535 2560	21100 21350	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	Omm Omm	0	23.59 23.42		10.1	14.19 13.57	13.57	23 23
LTE B7 LTE B7	5	AWAN	20	QPSK QPSK	1	0	2510 2510	20850 20850	100.00%	TB mode Left side 0mm TB mode Top side 0mm	0mm 0mm	0	23.69		3.22	19.26 25.90		23 23
LTE B12	5	AWAN	10	QPSK	1	0	2510	20850	100.00%	TB mode back 0mm	0mm	0	24.03		3.18	19.65		23.5
LTE B12 LTE B12	5	AWAN AWAN	10 10	QPSK QPSK	1	0	707.5	23095 23130	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	23.81 23.85		3.31 3.12	19.26 19.55	19.26	23.5 23.5
LTE B12 LTE B12	5	AWAN AWAN	10 10	QPSK QPSK	1	0	704 704	23060 23060	100.00% 100.00%	TB mode_Left side_0mm TB mode Top side 0mm	0mm 0mm	0	24.03 24.03		3.24 0.334	19.57 29.44		23.5 23.5
LTE B13 LTE B13	5	AWAN AWAN	10	QPSK QPSK	1	0 25	782 782	23230 23230	100.00%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	23.91 23.85		2.07 2.14	21.39 21.19		23.5 23.5
LTE B13	5	AWAN	10	QPSK	1	49	782	23230	100.00%	TB mode back 0mm	0mm	0	23.63		2.39	20.49	20.49	23.5
LTE B13 LTE B13	5	AWAN AWAN	10	QPSK QPSK	1	0	782 782	23230 23230	100.00% 100.00%	TB mode Left side 0mm TB mode Top side 0mm	0mm 0mm	0	23.91 23.91		2.25 0.255	21.03 30.49		23.5 23.5
LTE B14 LTE B14	5	AWAN	10	QPSK QPSK	1	0 25	793 793	23330 23330	100.00% 100.00%	TB mode back 0mm TB mode back 0mm	0mm 0mm	0	24.11 24.01		2.15	21.43 20.85		23.5 23.5
1 TE B14	5	AWAN AWAN	10	OPSK	1	49	793	23330	100.00% 100.00%	TB mode_back_0mm TB mode_Left side_0mm	0mm 0mm	0	23.85		2.03	21.42 21.25	20.85	23.5 23.5 23.5 23.5 23.5 23.5 23.5
LTE B14 LTE B14 LTE B17	5	AWAN	10	QPSK QPSK QPSK	1	0	793 793	23330 23330 23780	100.00%	TB mode Top side 0mm	0mm 0mm	0	24.11 24.11		0.238	30.99		23.5
LTE B17	5	AWAN AWAN	10	QPSK	1	0	709 710	23790	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	0mm	0	23.89 23.90		2.6	20.06 20.46		23.5
LTE B17 LTE B17	5	AWAN AWAN	10	QPSK QPSK	1	0	711 711	23800 23800	100.00%	TB mode back 0mm TB mode Left side 0mm	0mm 0mm	0	23.98 23.98		2.37	20.88 21.28	20.06	23.5 23.5
LTE B17 LTE B25	5	AWAN	10	QPSK QPSK	1	0	711 1860	23800 26140	100.00% 100.00%	TB mode Top side 0mm TB mode back 0mm	0mm 0mm	0	23.98 23.53		0.244 7.85	30.75 15.23		23.5 23
LTE B25	5	AWAN	20	OPSK	1	0	1880 1905	26340 26590	100.00%	TB mode_back_0mm TB mode_back_0mm	0mm	0	23.66		8.06 7.99	15.24	15.19	23
LTE B25 LTE B25 LTE B25	5	AWAN	20	QPSK QPSK QPSK	1	0	1880	26340	100.00% 100.00% 100.00%	TB mode Left side 0mm	Omm Omm	0	23.57 23.66		3.25	15.19 19.19	10.10	23 23 23
LTE B26	5	AWAN	15	QPSK	1	0	821.5	26340 26765	100.00%	TB mode_Top side_0mm TB mode_back_0mm	Omm Omm	0	23.66 24.29		2.24	26.44 21.43		23.5
LTE B26 LTE B26	5	AWAN AWAN	15 15	QPSK QPSK	1	0	831.5 841.5	26865 26965	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	24.18 24.14		2.11	21.58 21.09	21.09	23.5 23.5
LTE B26 LTE B26	5	AWAN	15	QPSK QPSK	1	0	821.5 821.5	26765 26765	100.00%	TB mode Left side 0mm TB mode Top side 0mm	0mm 0mm	0	24.29 24.29		2.2	21.51 31.19		23.5
LTE B30 LTE B30	5	AWAN	10	QPSK QPSK	1	0	2310 2310	27710 27710	100.00%	TB mode back 0mm TB mode back 0mm	0mm 0mm	0	22.47 22.53		5.51	15.70 15.59		22
LTE B30 LTE B30	5	AWAN	10	QPSK QPSK	1	49	2310 2310	27710	100.00%	TB mode_back_0mm TB mode_Left side_0mm	0mm 0mm	0	22.42		4.57	16.47	15.59	22
LTE B30	5	AWAN	10	QPSK	1	25 25	2310	27710	100.00%	TB mode_Top side_0mm	0mm	0	22.53		0.468	26.47		22
LTE B66 LTE B66	5	AWAN AWAN	20 20	QPSK QPSK	1	0	1720 1745	132072 132322	100.00% 100.00%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	23.81 23.58		7.38 6.87	15.77 15.86		23 23
LTE B66 LTE B66	5	AWAN AWAN	20 20	QPSK QPSK	1	0	1770 1720	132572 132072	100.00% 100.00%	TB mode back 0mm TB mode Left side 0mm	0mm 0mm	0	23.66 23.81		7.12	15.78 19.36	15.77	23 23
LTE B66	5	AWAN	20	QPSK	1	0	1720	132072	100.00%	TB mode Top side 0mm	0mm	0	23.81	21.614	0.7 5.99	26.00 14.48		23
LTE B38 LTE B38	5	AWAN	20 20	QPSK QPSK	1	0	2580 2595	37850 38000	63.30% 63.30%	TB mode back 0mm TB mode back 0mm	Omm Omm Omm	0	23.60 23.50	21.514	6.04	14.35		21 21
LTE B38 LTE B38	5	AWAN AWAN	20 20	QPSK QPSK	1	0	2610 2610	38150 38150	63.30% 63.30%	TB mode_back_0mm TB mode_Left side_0mm	0mm	0	23.20 23.60	21.214 21.614	6.42 2.67	13.78 17.99	13.78	21 21
LTE B38 LTE B41	5	AWAN	20	QPSK QPSK	1	0	2580 2506	37850 39750	63.30% 63.30%	TB mode_Top side_0mm TB mode_back_0mm	0mm 0mm	0	23.60 23.75	21.614 21.764	0.127 4.64	31.22		21
LTE B41 LTE B41	5	AWAN	20	QPSK QPSK	1	0	2549.5 2593	40185 40620	63.30% 63.30%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	23.89 23.92	21.904 21.934	6.59 6.04	14.36		21 21
LTE B41	5	AWAN	20	QPSK	1	0	2636.5	41055 41490	63.30%	TB mode back 0mm	0mm	0	23.80	21.814	5.78	14.84	14.36	21
LTE B41 LTE B41	5	AWAN AWAN	20	QPSK QPSK	1	0	2680 2593	40620	63.30% 63.30%	TB mode back 0mm TB mode Left side 0mm	0mm 0mm	0	23.82 23.92	21.834 21.934	4.11 2.39	16.34 18.79		21 21
LTE B41 LTE B41 PC2	5	AWAN AWAN	20 20	QPSK QPSK	1	0	2593 2506	40620 39750	63.30% 43.30%	TB mode Top side 0mm TB mode_back_0mm	0mm 0mm	0	23.92 25.82	21.934 22.185	0.124 6.26	31.64 14.86		21 22.4
LTE B41 PC2 LTE B41 PC2	5	AWAN AWAN	20 20	QPSK QPSK	1	0	2549.5 2593	40185 40620	43.30% 43.30%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	25.81 25.69	22.175 22.055	6.18 5.95	14.91 14.95		22.4 22.4
LTE B41 PC2 LTE B41 PC2	5	AWAN AWAN	20 20	QPSK QPSK	1	0	2636.5 2680	41055 41490	43.30% 43.30%	TB mode_back_0mm TB mode_back_0mm	0mm 0mm	0	25.83 25.84	22.195 22.205	6.05	15.02 14.81	14.81	22.4 22.4
LTE B41 PC2	5	AWAN	20	QPSK	1	0	2680	41490	43.30%	TB mode Left side 0mm	0mm	0	25.84	22.205	3.57	17.32		22.4
LTE B41 PC2 5G n2	5	AWAN AWAN	20 20	QPSK PV2 BPSK	1	0	2680 1860	41490 372000	43.30% 100.00%	TB mode Top side 0mm TB mode back 0mm	0mm 0mm	0	25.84 23.39	22.205	0.451 17.54	26.31 11.59		22.4
5G n2 5G n2	5	AWAN AWAN	20 20	PV2 BPSK PV2 BPSK	1	1	1880 1900	376000 380000	100.00% 100.00%	TB mode back 0mm TB mode back 0mm	0mm 0mm	0	23.28 23.43		15.42 18.6	12.04 11.38	11.38	23 23
5G n2 5G n2	5	AWAN AWAN	20	PV2 BPSK PV2 BPSK	1	1	1900	380000 380000	100.00% 100.00%	TB mode_Left side_0mm TB mode_Top side_0mm	Omm Omm	0	23.43 23.43		4.87	17.20 24.29		23 23
5G n5 5G n5	5	AWAN	20	PV2 BPSK PV2 BPSK	1	1	834 836.5	166800 167300	100.00%	TB mode back 0mm	0mm 0mm	0	23.43 23.53 23.56		3.35	18.92 19.03		23
5G n5	5	AWAN	20	PV2 BPSK	1	1	839	167800	100.00%	TB mode_back_0mm TB mode_back_0mm	0mm	0	23.63		3.44	18.91	18.91	23 23
5G n5 5G n5	5	AWAN	20 20	PV2 BPSK PV2 BPSK	1	1	839 839	167800 167800	100.00% 100.00%	TB mode Left side 0mm TB mode Top side 0mm	0mm 0mm	0	23.63 23.63		2.4 0.288	20.47 29.68		23 23
5G n12 5G n12	5	AWAN	15 15	PV2 BPSK PV2 BPSK	1	1	706.5 707.5	141300 141500	100.00% 100.00%	TB mode back 0mm TB mode back 0mm	Omm Omm	0	23.80 23.73		5.66 5.45	16.92 17.01		23 23
5G n12 5G n12	5	AWAN	15	PV2 BPSK PV2 BPSK	1	1	708.5	141700	100.00%	TB mode back 0mm TB mode Left side 0mm	0mm 0mm	0	23.71 23.80		5.72	16.78 16.94	16.78	23 23 23
5G n12 5G n66	5	AWAN	15	PV2 BPSK PV2 BPSK	1	1	706.5	141300	100.00%	TB mode_Leit side_omm TB mode_Top side_0mm TB mode_back_0mm	0mm 0mm	0	23.80		0.254	30.40		23
5G n66	5	AWAN	20	PV2 BPSK	1	1	1745	349000	100.00%	TB mode_back_0mm	0mm	0	23.38		13.7	12.74		23 23 23
5G n66 5G n66	5	AWAN AWAN	20 20	PI/2 BPSK PI/2 BPSK	1	1	1770 1720	354000 344000	100.00% 100.00%	TB mode_back_0mm TB mode_Left side_0mm	0mm 0mm	0	23.55 23.67		13.54 3.11	12.88 19.39	12.74	23 23
5G n66	5	AWAN	20	PV2 BPSK	1	1	1720	344000	100.00%	TB mode Top side 0mm	0mm	0	23.67		0.677	26.01		23

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 90 days only.

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Tx8 (Tablet mode)

1 4 4000 20 6000 6000 6000 6000 <th>Band / Mode</th> <th>Antenna</th> <th>Antenna Vendor</th> <th>Bandwidth</th> <th>Modulation</th> <th>RB size</th> <th>RB offset</th> <th>Frequency (MHz)</th> <th>Channel</th> <th>Duty cycle</th> <th>Test position</th> <th>Test Distance</th> <th>MPR (dBm)</th> <th>Measured conducted power (dBm)</th> <th>TDD Correction</th> <th>Measured 1g-SAR (W/Kg)</th> <th>Plimit** (dBm)</th> <th>Minimum Plimit** (dBm)</th> <th>Pn (dl</th>	Band / Mode	Antenna	Antenna Vendor	Bandwidth	Modulation	RB size	RB offset	Frequency (MHz)	Channel	Duty cycle	Test position	Test Distance	MPR (dBm)	Measured conducted power (dBm)	TDD Correction	Measured 1g-SAR (W/Kg)	Plimit** (dBm)	Minimum Plimit** (dBm)	Pn (dl
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5 Abox Abox Abox Abox Abox Abox Abox Abox		8	AWAN	20	QPSK	1	0	1900	19100	100.00%		0mm	0	23.98		0.155	30.108		
1 4 4 6		8	AWAN	20	QPSK	1	0	1860	18700	100.00%		0mm	0	23.92		0.287	27.372	1	
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4 400 30 095 1 1 0 000 000 0 0.000 </td <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td>-</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td>13.5</td> <td></td> <td></td> <td>+</td>							-									13.5			+
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Image Image <th< td=""><td></td><td>8</td><td></td><td></td><td></td><td>1</td><td>0</td><td>3560</td><td></td><td></td><td></td><td></td><td>0</td><td></td><td></td><td>0.061</td><td></td><td></td><td>ſ</td></th<>		8				1	0	3560					0			0.061			ſ
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6 AviAv 20 0.92% 1 0 350 3694 65.00 Take mode, Rept add, mode 0m 0 71.45 19.35 0.931 23.15 6 AviAviA 20 OPEK 1 0 3607 63.376 Taket mode, back down 0m 0 71.45 19.35 0.417 35.07 6 AviAviA 20 OPEK 1 0 3647 63.376 Taket mode, back down 0m 0 71.45 19.35 0.417 36.375 6 AviAviA 20 OPEK 1 0 117.45 19.322 10.00% 14.84 0.0 23.6 23.1 38.37 6 AviAviA 20 OPEK 1 0 117.1 132.27 10.00% 14.84 0.0 23.6 23.1 23.63 23.11 23.63 23.11 23.63 23.11 23.63 23.11 23.63 23.11 23.64 13.12 13.12 13.12	LIE D40			20				3646.7	56207	63.30%	Tablet mode_Right side_0mm	0mm			19.52			14.77	
8 Avrial 20 OPSK 1 0 3003.3 5977.3 64.37% Table mode back dom Dom 0 21.8 1920 0.217 3927 1920 1920 0.217 3927 1920 1920 1920 2017 2481 2017 1920 2017 1920 2017 1920 2017 1920 2017 1920								3690	56640						19.46			4	
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B AVVAN 20 OPSK 1 0 170 132572 1000% Tablet mode back, Dmm mm 0 23.94 0.204 28.975 B AVVAN 20 OPSK 1 0 170 13207 100.0% Tablet mode back, Dmm mm 0 23.94 0.315 27.175 B AVVAN 20 P22 BPSK 1 1 1899 72000 100.0% Tablet mode back, Dmm 0m 0 23.94 24.31 17.93 2	LTE B66			20							Tablet mode_Right side_omm							18.03	
8 AVANA 20 OPEK 1 0 132072 10000% Tablet mode back, form 0mm 0 23.96 0.311 27.05 8 AVVAN 20 OPEK 1 0 1790 13222 100.05 Tablet mode back, form 0mm 0 23.94 0.301 27.17 8 AVVAN 20 P12 PES 1 1 1990 32000 100.05 Tablet mode back, form 0mm 0 23.94	212 200		AWAN	20	OPSK			1770	132572	100.00%	Tablet mode Right side 0mm	0mm				0.204			
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8 AVXAN 200 P1/2 BPSK 1 1 1880 370000 1000% Table mode Top dots Top		8		20	QPSK	1	0		132572	100.00%	Tablet mode_back_0mm	0mm	0	23.94		0.309			
8 AWAR 20 P/2 BPSK 1 1 1900 380000 100.0% Table mode, Top side, 0mm 0mm 0 23.05 22.44 177.03 6 AWAR 20 P/2 BPSK 1 1 1800 370200 100.00% Table mode, Top side, 0mm 0mm 0 23.04 0.028 33.147 177.03 6 AWAR 20 P/2 BPSK 1 1 1800 370200 100.00% Table mode, Rupt side, 0mm 0mm 0 23.04 0.028 33.147 177.03 6 AWAR 20 P/2 BPSK 1 1 1800 370200 100.00% Table mode, Rupt side, 0mm 0mm 0 23.48 0.166 20.01 8 AWAR 20 P/2 BPSK 1 1 2500 512000 100.05% Table mode, Rupt side, 0mm 0mm 0 23.48 113.2 10.027 6 AWAR 20 P/2 BPSK 1 1 2500		8	AWAN			1	1			100.00%	Tablet mode_Top side_0mm								
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- End of report -

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 90 days only.

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